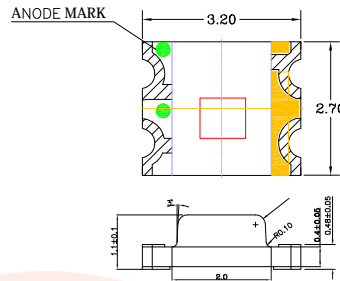


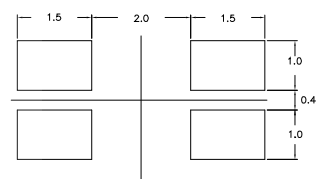
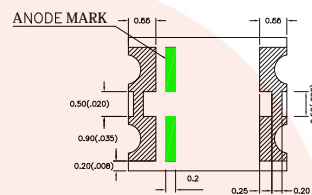
### ● Features:

1. Lens Appearance : Black
2. The BPD-HQDA3B-TRB is a NIP silicon photo diode in a 3.2x2.7x1.1mm SMD type package.
3. Suitable for all SMT assembly methods.
4. Compatible with infrared and vapor phase reflow solder process.
5. Compatible with automatic placement equipment.
6. This product doesn't contain restriction
7. Substance, comply ROHS standard.
8. Green anode, yellow as the cathode

### ● Package Dimensions:



Anode ● —▶ Cathode



#### NOTES:

1. All dimensions are in millimeters .
2. Tolerance is  $\pm 0.10\text{mm}$  unless otherwise specified.
3. Specifications are subject to change without notice.

### ● Applications:

1. Infrared Sensor ;
2. Smoke Detector.
3. High speed photo detector;

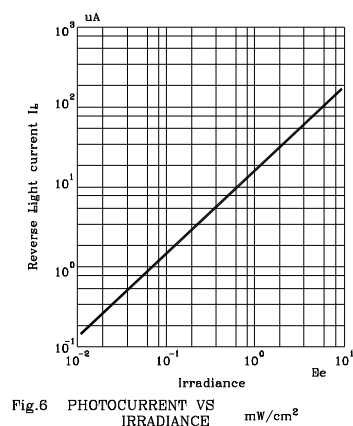
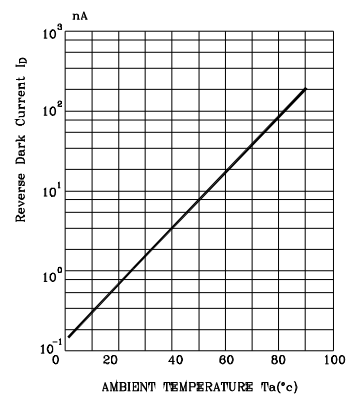
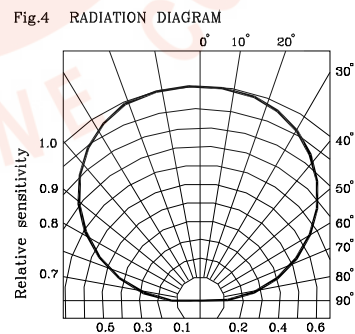
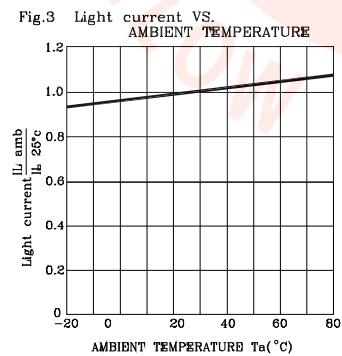
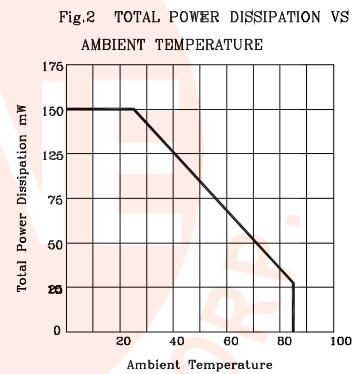
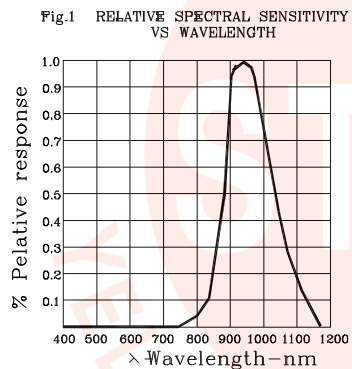
### ● Absolute Maximum Ratings( $T_a=25^\circ\text{C}$ )

Parameter	Symbol	Rating	Unit
Power Dissipation	Pd	150	mW
Operating Temperature	Topr	-40°C~85°C	-
Storage Temperature	Tstg	-40°C~85°C	-
Soldering Temperature	Tsol	See Page6	-

● Electrical and optical characteristics(Ta=25°C)

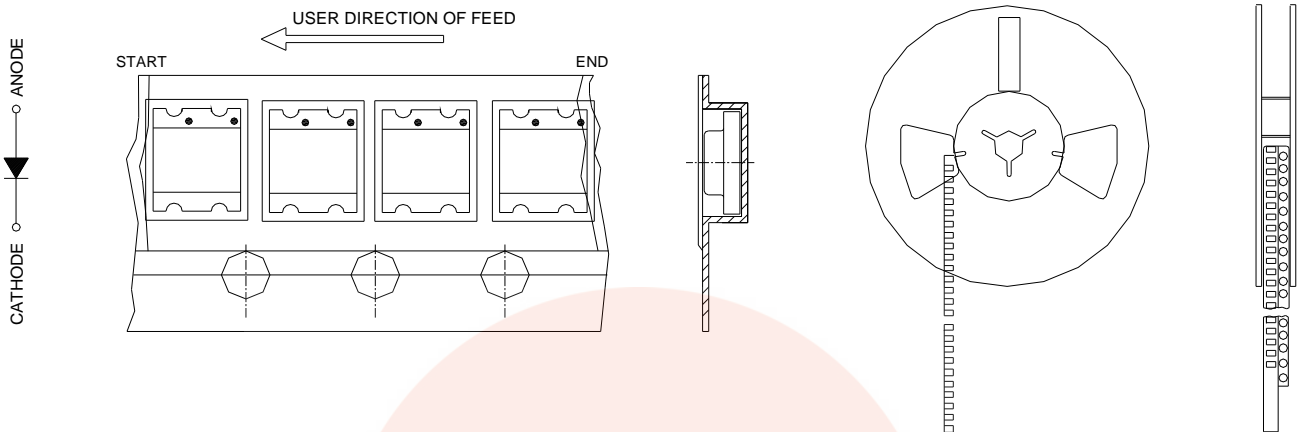
Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Spectrum Sensitivity	$\lambda_p$	-	-	940	-	nm
Reverse Breakdown Voltage	$V_{BR}$	$I_R=100\mu A$ , $H=0\text{mw}/\text{cm}^2$	60			V
Reverse Dark Current	$I_D$	$V_R=10\text{V}$ , $H=0\text{mw}/\text{cm}^2$	-	-	100	nA
Reverse light Current	$I_L$	$V_R=5\text{V}$ , $H=1\text{mw}/\text{cm}^2$ , $\lambda_p=940\text{nm}$	17.83	25	-	$\mu A$
Total Capacitance	$C_T$	$V_R=5\text{V}$ , $H=0\text{mw}/\text{cm}^2$ , $F=1\text{MHz}$	-	9	-	pF
Rise/Fall Time	$T_R/T_F$	$V_R=20\text{V}$ , $R_L=1\text{KW}$ , $\lambda_p=940\text{nm}$	-	50	-	ns

● Typical Electro-Optical Characteristics Curves

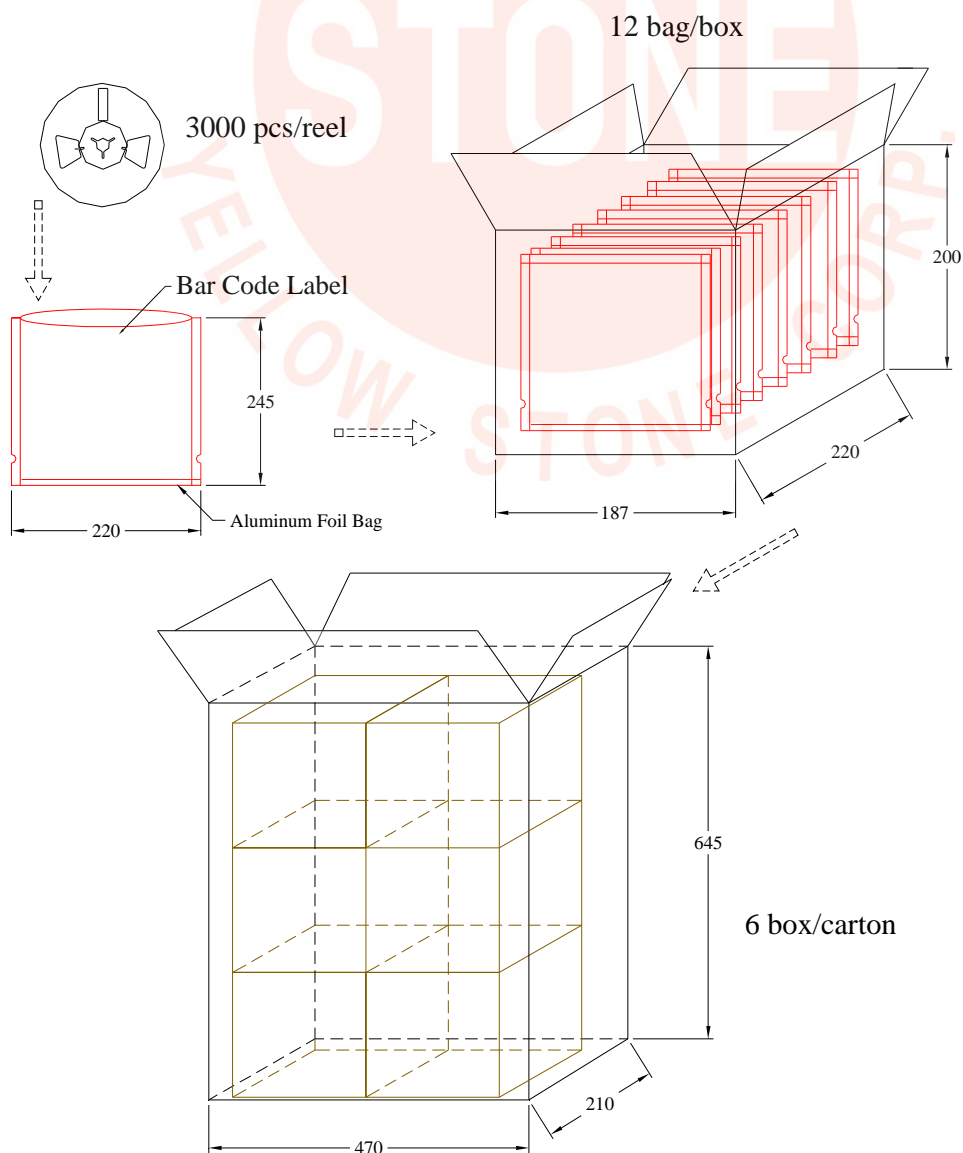


● Tapping and packaging specifications(Units: mm)

Quantity: 3000PCS



● Package Method:(unit:mm) Vacuum





● Bin Limits

Reverse light Current Bin Limits ( $V_R=5V$ ,  $H=1\text{mw/cm}^2$ ,  $\lambda_p=940\text{nm}$ )

BIN CODE	Min. (uA)	Max. (uA)
W	17.83	21.39
X	21.39	25.67
Y	25.67	30.81
Z	30.81	36.97

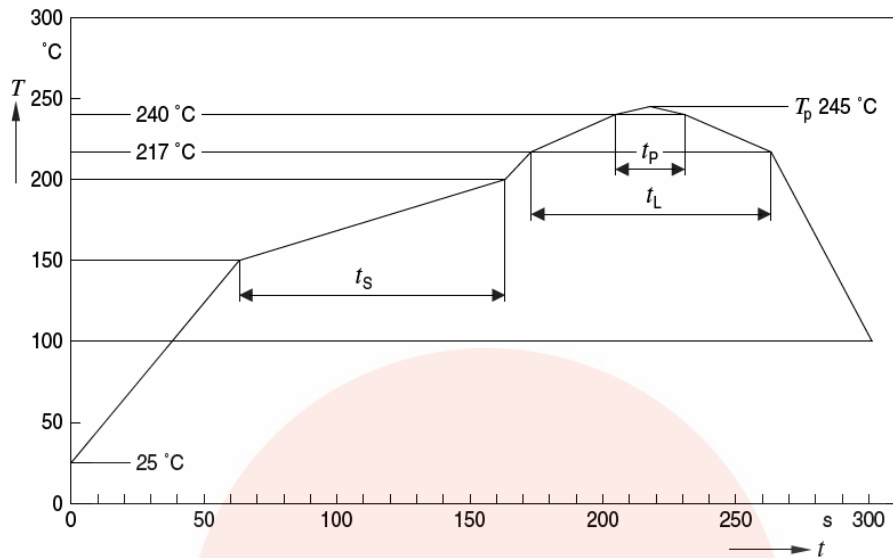




● Reliability Test

Classification	Test Item	Reference Standard	Test Conditions	Result
Endurance Test	Operation Life	MIL-STD-750D:1026 MIL-STD-883D:1005 JIS-C-7021 :B-1	Ta: Under room temperature Test time:1,000hrs IF=Product Recommended IF	0/32
	High Temperature High Humidity Storage	MIL-STD-202F:103B JIS-C-7021 :B-11	Ta:85±5℃ RH:90%-95% Test time:240hrs	0/32
	High Temperature Storage	MIL-STD-883:1008 JIS-C-7021 :B-10	Ta:100±5℃ Test time:1,000hrs	0/32
	Low Temperature Storage	JIS-C-7021 :B-11	Ta: -45±5℃ Test time=1,000hrs	0/32
Environmental Test	Temperature Cycling	MIL-STD-202F:107D MIL-STD-750D:1051 MIL-STD-883D:1010 JIS-C-7021 :A-2	Ta:-35±5℃ ~25±5℃ ~85±5℃ ~25±5℃ 30min 5min 30min 5min Time: 5cycles	0/32
	Thermal Shock	MIL-STD-202F:107D(1980) MIL-STD-750D:1051(95) MIL-STD-883D:1011(1991)	Ta:-45±5℃ ~+85±5℃ 20min 20 min Time: 10cycles	0/32
	Wetting balance	MIL-STD-883:2003 MIL-STD-202F:208D MIL-STD-883D:2003	Ta:230±5℃ Time:5±0.5s	0/32
	Solder Resistance	MIL-STD-202F:210A MIL-STD-883D:1011 JIS-C-7021 :A-1	Ta:260±10℃ Time:10±1s	0/32

## ● IR-Reflow Soldering



Profile Feature	Symbol	Pb-Free (SnAgCu) Assembly			Unit
		Minimum	Recommendation	Maximum	
Ramp-up rate to preheat <sup>*)</sup> 25 $^{\circ}\text{C}$ to 150 $^{\circ}\text{C}$			2	3	K/s
Time $t_s$ $T_{smin}$ to $T_{smax}$	$t_s$	60	100	120	s
Ramp-up rate to peak <sup>*)</sup> $T_{smax}$ to $T_p$			2	3	K/s
Liquidus temperature	$T_L$		217		$^{\circ}\text{C}$
Time above liquidus temperature	$t_L$		80	100	s
Peak temperature	$T_p$		245	260	$^{\circ}\text{C}$
Time within 5 $^{\circ}\text{C}$ of the specified peak temperature $T_p - 5\text{ K}$	$t_p$	10	20	30	s
Ramp-down rate* $T_p$ to 100 $^{\circ}\text{C}$			3	6	K/s
Time 25 $^{\circ}\text{C}$ to $T_p$				480	s

All temperatures refer to the center of the package, measured on the top of the component

\* slope calculation  $DT/Dt$ ;  $Dt$  max. 5 s; fulfillment for the whole T-range

1. Avoid any external stress applied to the resin while the LEDs are at high temperature, especially during soldering.
2. Avoid rapid cooling or any excess vibration during temperature ramp-down process.
3. Although the soldering condition is recommended above, soldering at the lowest possible temperature is feasible for the LEDs.

## ● IRON Soldering

**350 $^{\circ}\text{C}$  Within 3 sec.,One time only.**



● **Notes for designing:**

Care must be taken to provide the current limiting resistor in the circuit so as to drive the LEDs within the rated figures. Also, caution should be taken not to overload LEDs with instantaneous voltage at the turning ON and OFF of the circuit.

When using the pulse drive care must be taken to keep the average current within the rated figures. Also, the circuit should be designed so as to be subjected to reverse voltage when turning off the LEDs.

● **Storage:**

In order to avoid the absorption of moisture, it is recommended to solder LEDs as soon as possible after unpacking the sealed envelope.

If the envelope is still packed, to store it in the environment as following:

- (1) Temperature : 5°C -30°C (41°F) Humidity : RH 60% Max.
- (2) After this bag is opened, devices that will be applied to infrared reflow, vapor-phase reflow, or equivalent soldering process must be:
  - a. Completed within 168 hours.
  - b. Stored at less than 30% RH.
- (3) Devices require baking before mounting, if:
  - (2) a or (2) b is not met.
- (4) If baking is required, devices must be baked under below conditions:  
48 hours at 60°C±3°C.

● **Package and Label of Products:**

- (1) Package: Products are packed in one bag of 3000 pcs (one taping reel) and a label is attached on each bag.
- (2) Label:

